Search Notes



Application/Control No.

10519155

MIKOSHIBA ET AL.

Applicant(s)/Patent Under Reexamination

Examiner

Art Unit

Finn, Meghan

1609

SEARCHED

Class	Subclass	Date	Examiner
514	412,310,563	5/30/07	MF

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Search Notes	Date	Examiner	
Inventor Name Search	5/29/07	MF	
East (see attached sheet)	5/29/07	MF	
West (see attached sheet)	5/23/07	MF	
Pubmed	5/24/07	MF	
Plus Search (see attached sheet)	5/24/07	MF	
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STN (see attached sheet)	5/31/07	MF	
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